

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/788,797	ANKERST, MIHAEL	
Examiner		Art Unit	2166	Page 1 of 1
JOON H. HWANG				

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ankerst et al. ("DataJewel : Tightly Integrating Visualization with Temporal Data Mining", ICDM Workshop on Visual Data Mining, Melbourne, FL, 2003, 19 pages, retrieved from <a href="http://ankerst.de/Mihael/publications.html">http://ankerst.de/Mihael/publications.html</a> on 5/7/08)
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